

MOS FIELD EFFECT POWER TRANSISTOR  
**2SK1499/2SK1500**

SWITCHING  
 N-CHANNEL POWER MOS FET  
 INDUSTRIAL USE

**DESCRIPTION**

The 2SK1499/2SK1500 is N-channel MOS Field Effect Transistor designed for high voltage switching applications.

**FEATURES**

- Low On-state Resistance  
 $R_{DS(on)} \leq 0.25 \Omega / 0.27 \Omega$  ( $V_{GS} = 10 \text{ V}$ ,  $I_D = 13 \text{ A}$ )
- Low  $C_{iss}$   $C_{iss} = 3\ 300 \text{ pF TYP.}$
- Built-in G-S Gate Protection Diode
- High Avalanche Capability Ratings

**QUALITY GRADE**

Standard

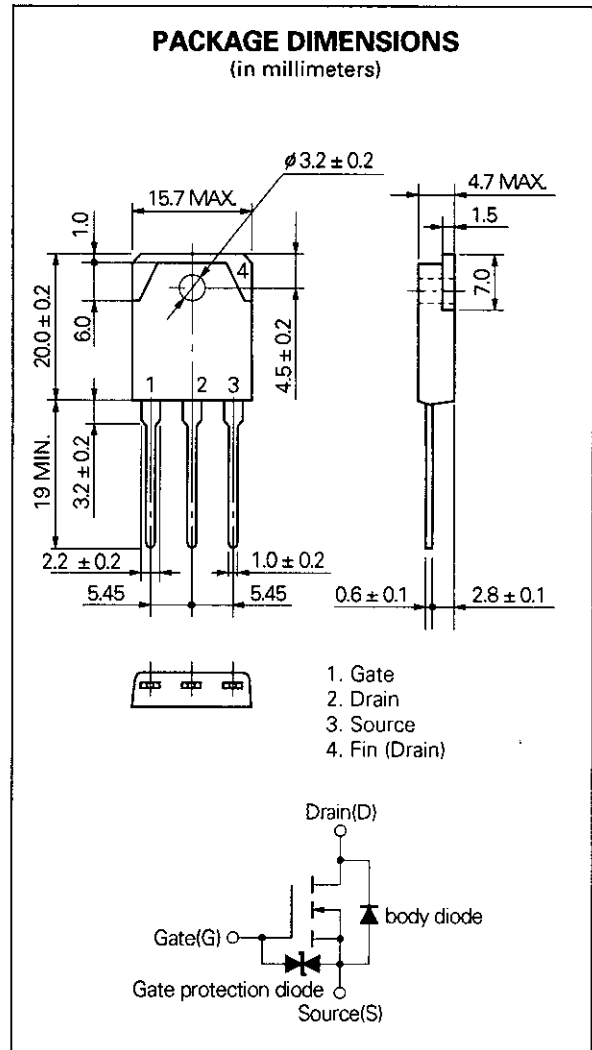
Please refer to "Quality grade on NEC Semiconductor Devices" (Document number IEI-1209) published by NEC Corporation to know the specification of quality grade on the devices and its recommended applications.

**ABSOLUTE MAXIMUM RATINGS ( $T_a = 25 \text{ }^\circ\text{C}$ )**

Drain to Source Voltage	$V_{DSS}$	450/500	V
(2SK1499/2SK1500)			
Gate to Source Voltage	$V_{GSS}$	$\pm 30$	V
Drain Current (DC)	$I_{D(DC)}$	$\pm 25$	A
Drain Current (pulse)	$I_{D(pulse)^*}$	$\pm 100$	A
Total Power Dissipation ( $T_c = 25 \text{ }^\circ\text{C}$ )	$P_T$	160	W
Channel Temperature	$T_{ch}$	150	$^\circ\text{C}$
Storage Temperature	$T_{stg}$	-55 to +150	$^\circ\text{C}$
Single Avalanche Current	$I_{AS}^{**}$	37.5	A
Single Avalanche Energy	$E_{AS}^{**}$	907	mJ

\*  $PW \leq 10 \mu\text{s}$ , Duty Cycle  $\leq 2 \%$

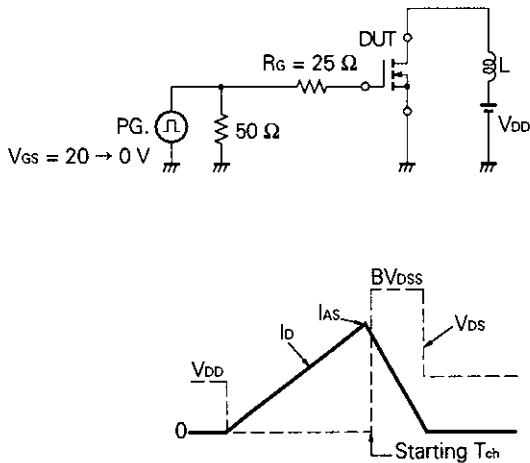
\*\* Starting  $T_{ch} = 25 \text{ }^\circ\text{C}$ ,  $R_G = 25 \Omega$ ,  $V_{GS} = 20 \text{ V} \rightarrow 0$



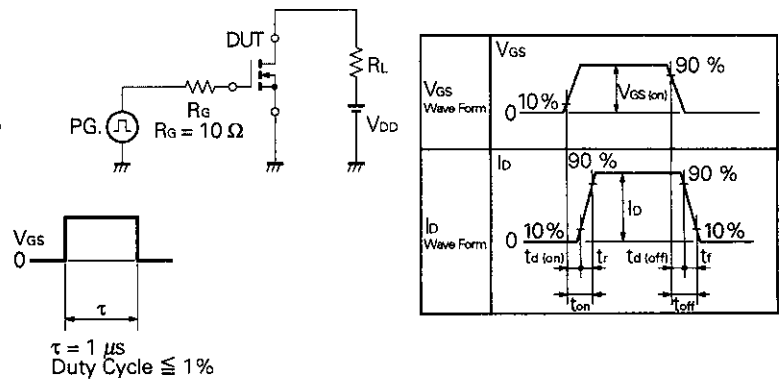
**ELECTRICAL CHARACTERISTICS (T<sub>a</sub> = 25 °C)**

CHARACTERISTIC	SYMBOL	MIN.	TYP.	MAX.	UNIT	TEST CONDITIONS
Drain to Source On-state Resistance (2SK1499)	R <sub>DS(on)</sub>		0.20	0.25	Ω	V <sub>GS</sub> = 10 V, I <sub>D</sub> = 13 A
Drain to Source On-state Resistance (2SK1500)	R <sub>DS(on)</sub>		0.22	0.27	Ω	
Gate to Source Cutoff Voltage	V <sub>GS(off)</sub>	2.5		3.5	V	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 1 mA
Forward Transfer Admittance	y <sub>fs</sub>	8.0			S	V <sub>DS</sub> = 10 V, I <sub>D</sub> = 13 A
Drain Leakage Current (2SK1499)	I <sub>DSS</sub>			100	μA	V <sub>DS</sub> = 450 V, V <sub>GS</sub> = 0
Drain Leakage Current (2SK1500)	I <sub>DSS</sub>			100	μA	V <sub>DS</sub> = 500 V, V <sub>GS</sub> = 0
Gate to Source Leakage Current	I <sub>GSS</sub>			±10	μA	V <sub>GS</sub> = ±30 V, V <sub>DS</sub> = 0
Input Capacitance	C <sub>iss</sub>		3 300		pF	V <sub>DS</sub> = 10 V V <sub>GS</sub> = 0 f = 1 MHz
Output Capacitance	C <sub>oss</sub>		1 100		pF	
Reverse Transfer Capacitance	C <sub>rss</sub>		480		pF	
Turn-On Delay Time	t <sub>d(on)</sub>		50		ns	V <sub>GS</sub> = 10 V V <sub>DD</sub> = 150 V I <sub>D</sub> = 13 A, R <sub>G</sub> = 10 Ω R <sub>L</sub> = 11.5 Ω
Rise Time	t <sub>r</sub>		130		ns	
Turn-Off Delay Time	t <sub>d(off)</sub>		180		ns	
Fall Time	t <sub>f</sub>		70		ns	
Total Gate Charge	Q <sub>G</sub>		115		nC	V <sub>GS</sub> = 10 V I <sub>D</sub> = 25 A V <sub>DD</sub> = 400 V
Gate to Source Charge	Q <sub>GS</sub>		20		nC	
Gate to Drain Charge	Q <sub>GD</sub>		70		nC	
Diode Forward Voltage	V <sub>FS(D)</sub>		1.0		V	I <sub>D</sub> = 25 A, V <sub>GS</sub> = 0
Reverse Recovery Time	t <sub>rr</sub>		670		ns	I <sub>D</sub> = 25 A, V <sub>GS</sub> = 0
Reverse Recovery Charge	Q <sub>rr</sub>		7.0		μC	di/dt = 50 A/μs

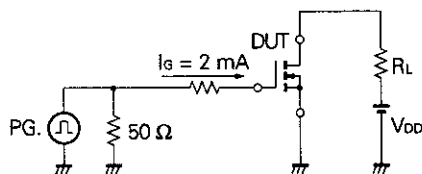
**Test Circuit 1: Avalanche Capability**



**Test Circuit 2: Switching Time**

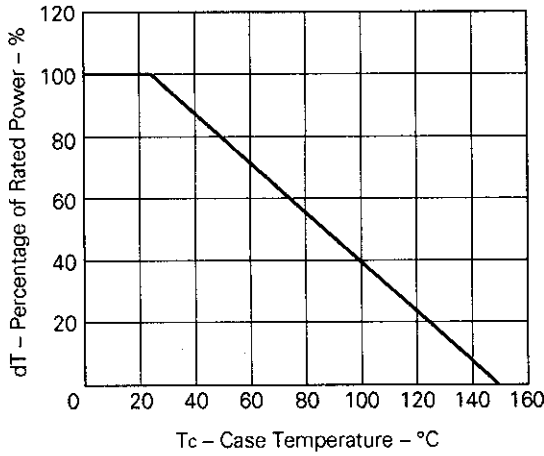


**Test Circuit 3: Gate Charge**

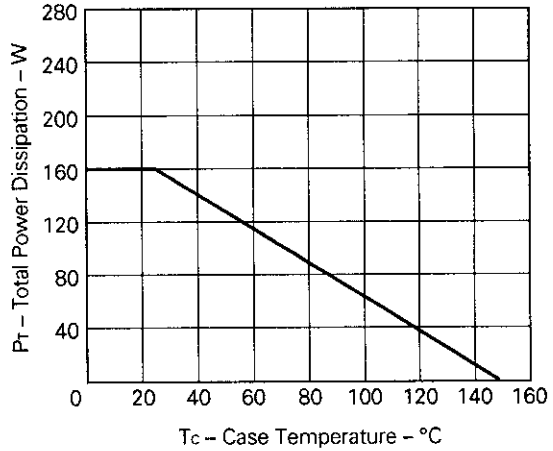


TYPICAL CHARACTERISTICS ( $T_a = 25^\circ\text{C}$ )

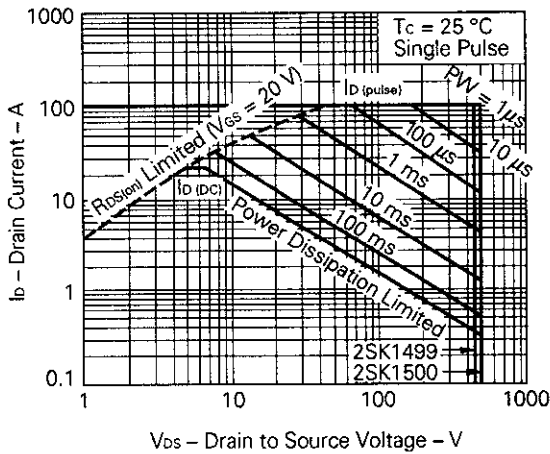
DERATING FACTOR OF FORWARD BIAS SAFE OPERATING AREA



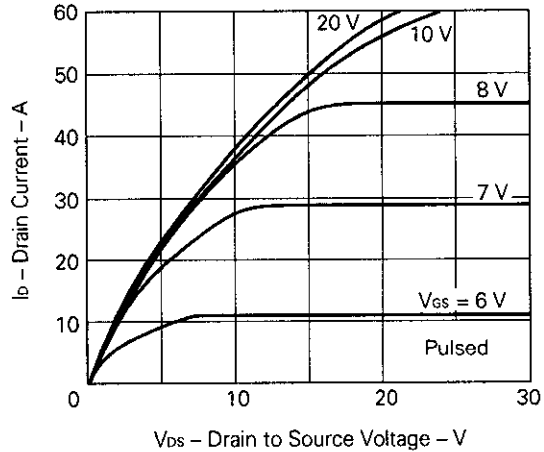
TOTAL POWER DISSIPATION vs. CASE TEMPERATURE



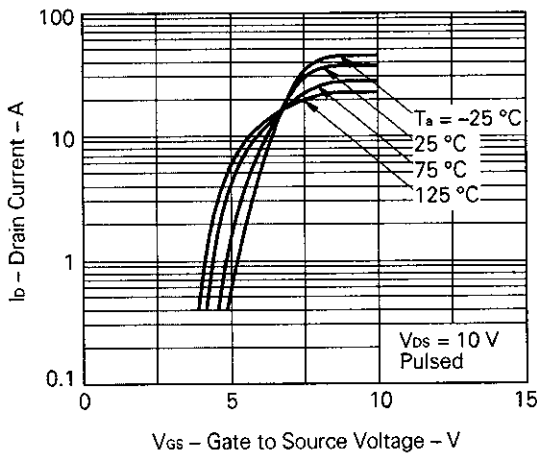
FORWARD BIAS SAFE OPERATING AREA



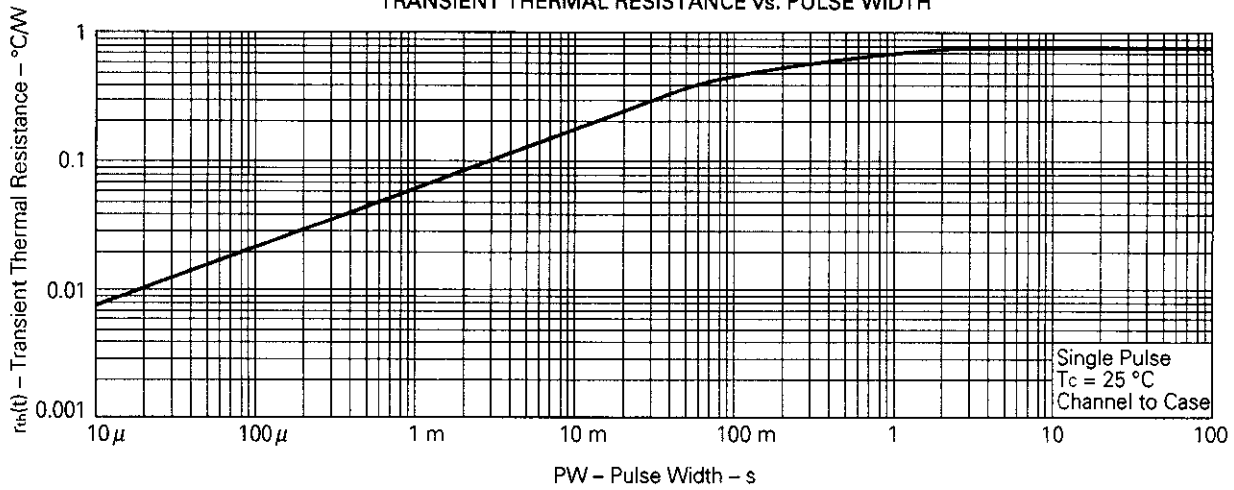
DRAIN CURRENT vs. DRAIN TO SOURCE VOLTAGE



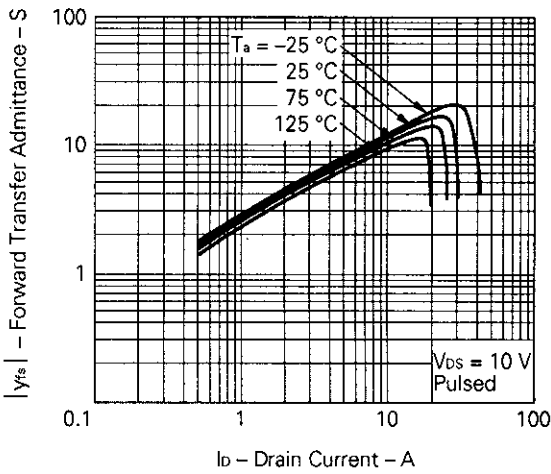
TRANSFER CHARACTERISTICS



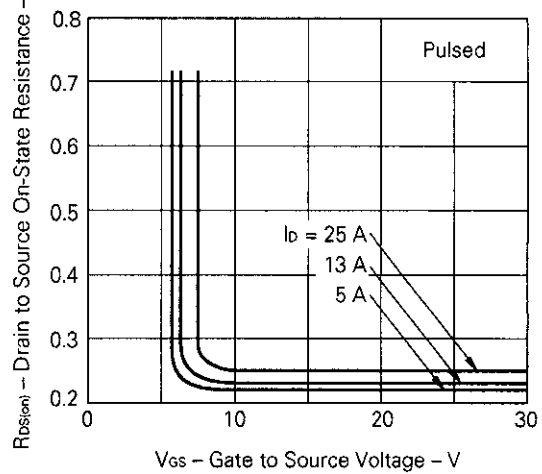
TRANSIENT THERMAL RESISTANCE vs. PULSE WIDTH



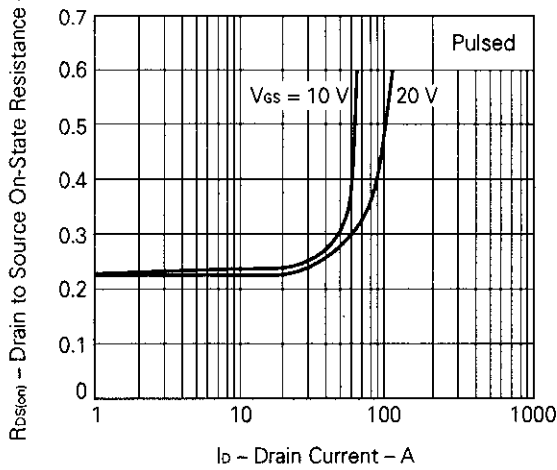
FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT



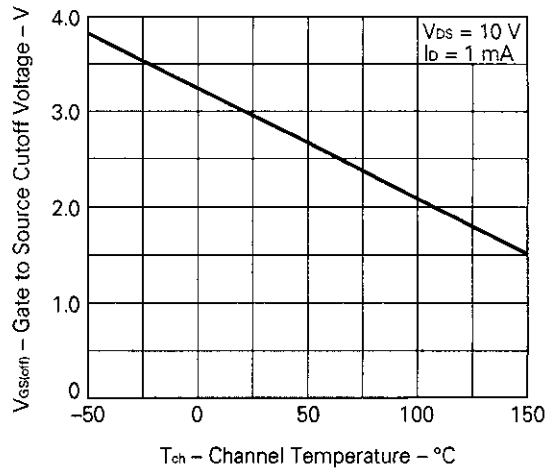
DRAIN TO SOURCE ON-STATE RESISTANCE vs. GATE TO SOURCE VOLTAGE



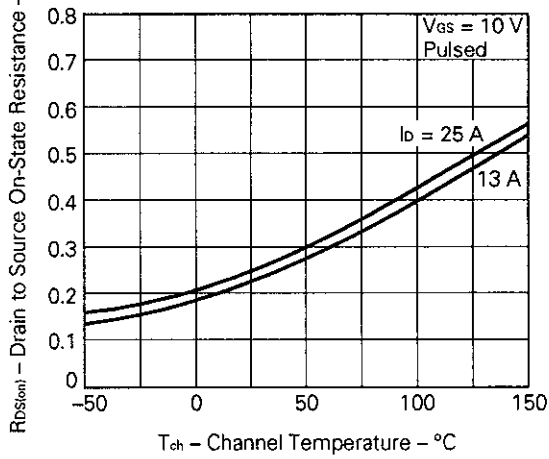
DRAIN TO SOURCE ON-STATE RESISTANCE vs. DRAIN CURRENT



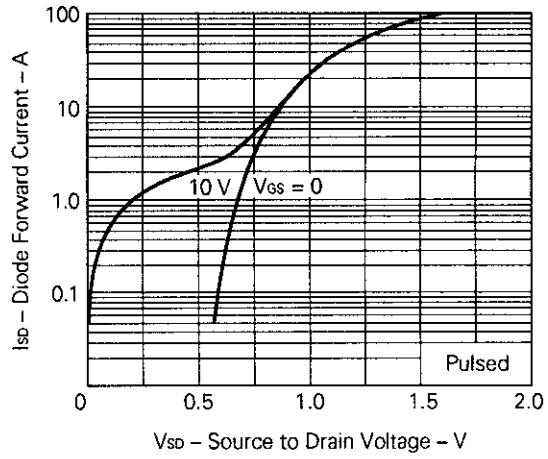
GATE TO SOURCE CUTOFF VOLTAGE vs. CHANNEL TEMPERATURE



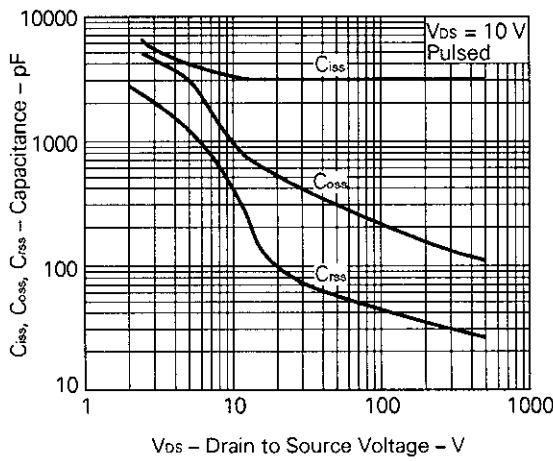
**DRAIN TO SOURCE ON-STATE RESISTANCE vs. CHANNEL TEMPERATURE**



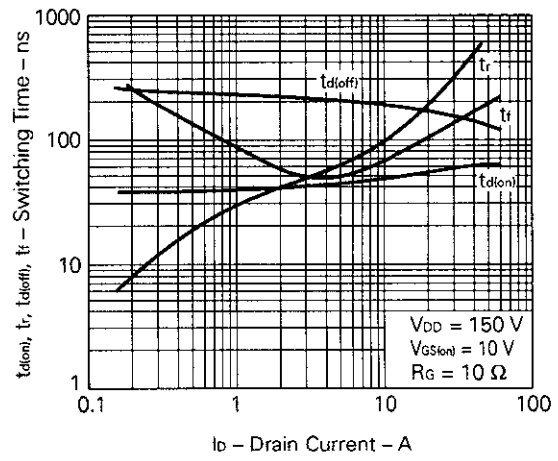
**SOURCE TO DRAIN DIODE FORWARD VOLTAGE**



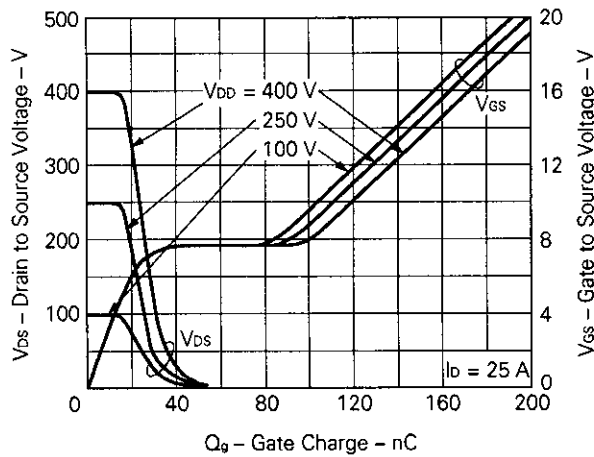
**CAPACITANCE vs. DRAIN TO SOURCE VOLTAGE**



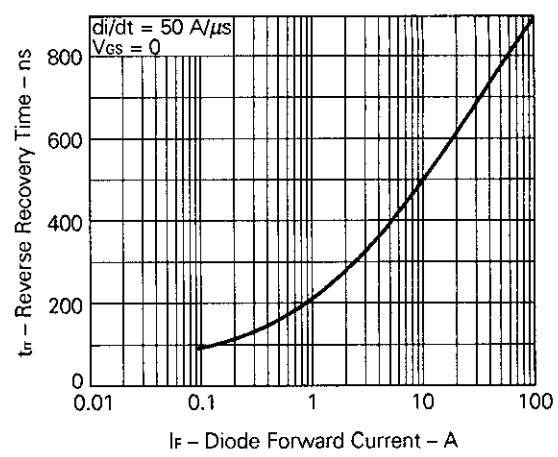
**SWITCHING CHARACTERISTICS**



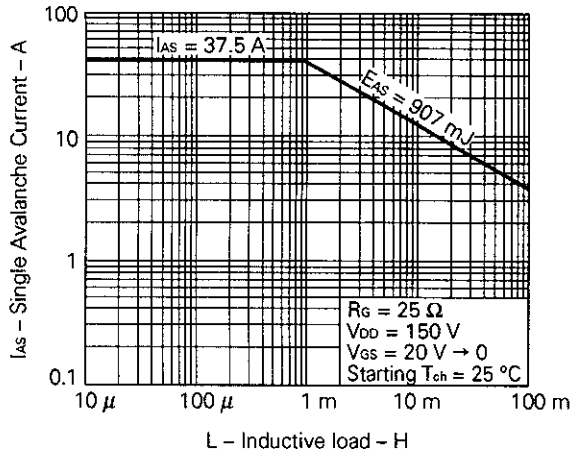
**DYNAMIC INPUT CHARACTERISTICS**



**REVERSE RECOVERY TIME vs. DIODE FORWARD CURRENT**



SINGLE AVALANCHE CURRENT vs. INDUCTIVE LOAD



SINGLE AVALANCHE ENERGY vs. STARTING CHANNEL TEMPERATURE

